

Notice of References Cited	Application/Control No. 09/941,512	Applicant(s)/Patent Under Reexamination SAFADI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,249,290 B1	06-2001	Herndon et al.	345/660
*	B	US-6,518,986 B1	02-2003	Mugura, Kazuto	715/810
*	C	US-6,745,391 B1	06-2004	Macrae et al.	725/42
*	D	US-6,526,577 B1	02-2003	Knudson et al.	725/40
*	E	US-6,704,028 B2	03-2004	Wugofski, Theodore D.	715/719
*	F	US-6,657,647 B1	12-2003	Bright, Walter G.	715/856
*	G	US-6,614,804 B1	09-2003	McFadden et al.	370/468
*	H	US-6,466,203 B2	10-2002	Van Ee, Jan	345/173
*	I	US-6,396,507	05-2002	Kaizuka et al.	345/661
*	J	US-6,169,543 B1	01-2001	Wehmeyer, Keith Reynolds	725/47
*	K	US-5,767,919	06-1998	Lee et al.	725/37
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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